CLAIMS

1. A microwave plasma processing method for introducing microwaves into a plasma processing chamber, and transforming a processing gas into plasma to form a thin film layer on a base substance disposed in the plasma processing chamber, the method characterized by:

fixing the base substance coaxially with a central axis of the plasma processing chamber;

setting a standing wave mode of the microwaves in the plasma processing chamber to a TE mode or a TEM mode from a mouth portion to a body portion of the base substance; and

setting a mode having both the TE mode and a TM mode in a bottom portion of the base substance.

- 2. The microwave plasma processing method according to claim 1, comprising inserting a metallic processing gas supply member into the base substance on the central axis of the plasma processing chamber so as not to reach the bottom portion of the base substance.
- 3. The microwave plasma processing method according to claim 1 or 2, comprising supplying the microwaves to the plasma processing chamber from a side surface of the plasma processing chamber at a position between the mouth portion and the bottom portion of the base substance.
 - 4. The microwave plasma processing method

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according to claims 1 to 3, wherein a mode of the microwaves before introduced into the plasma processing chamber is set to the TE mode and the TM mode.

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5. The microwave plasma processing method according to claims 1 to 4, wherein a degree of vacuum inside the base substance is higher than a degree of vacuum outside the base substance.